

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/022,909	YAMAGA, YOKO
<b>Examiner</b>	<b>Art Unit</b>	
Annan Q. Shang	2623	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner